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CRYSTAL UNITS IN METAL HOLDER,

BASED ON TYPE T2111,

FREQUENCY RANGE 0.8 - 50MHZ

ESCC Detail Specification No. 3501/003

ISSUE 1 October 2002



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Pages 1 to 26

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BASED ON TYPE T2111,

FREQUENCY RANGE 0.8 - 50MHZ

ESA/SCC Detail Specification No. 3501/003

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space components coordination group

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lssue/Rev.	Date	SCCG Chairman	ESA Director General or his Deputy			
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DOCUMENTATION CHANGE NOTICE

Rev. Letter	Rev. Date	CHANGE Reference Item	Approved DCR No.
Letter	Date	Heterence Item This Issue supersedes Issue 2 and incorporates all modifications defined in Revisions 'A', 'B', 'C', 'D' and 'E' to Issue 2 and the changes agreed in the following DCRs:- Cover Page DCN Table 1(a) : Storage Temperature Range column deleted Table 1(b) : No. 4, in Remarks, Note number amended : No. 5, in Remarks, Note number amended : No. 5, in Remarks, Note number amended : Existing Note 3 added : Existing Note 3 renumbered as "4" Table 1(c) : Item 20 deleted : Existing Note 3 renumbered as "20" Figure 2 : Drawing and Table amended : Vibration Axes and Notes added Para. 4.5.1 : Existing text deleted and new text added Para. 4.5.5 : Deleted in toto Para. 4.6.1 : Second sentence rewritten Para. 4.6.3 : Deleted in toto Para. 4.6.4 : Renumbered to "4.6.3" Table 6 : Table reformatted Ind. Tables 1(a) : Item 20 deleted	DCR No. None 221336 221336 221336 221336 221336 221336 221336 221336 221381 221341 221465 221465 221465 221341 221341 221341 221341 23799/ 221341/ 22136 221336

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5	Electrical Circuit for Burn-in and Life Test	N/A

APPENDICES (Applicable to specific Manufacturers only)

None.



1. <u>GENERAL</u>

1.1 <u>SCOPE</u>

This specification details the values, physical and electrical characteristics, test and inspection data for Crystal Units in Metal Holder, based on Type T2111, Frequency Range 0.8 - 50MHz.

It shall be read in conjunction with ESA/SCC Generic Specification No. 3501, the requirements for which are supplemented herein.

1.2 <u>TYPE VARIANTS</u>

A list of the type variants of the crystal units specified herein, which are also covered by this specification, is given in "Table 1(a) - Type Variant Summary".

For each type variant, the full electrical and physical characteristics are given in individual Tables 1(a) - "Type Variant Detailed Information" at the end of this specification.

The contents of the individual Tables 1(a) shall be as shown in Table 1(c) and the characteristics therein listed shall relate to the design parameters of the individual crystal units, optimised for the intended application.

The specific characteristics shall be negotiated between the Manufacturer and the Orderer. The Manufacturer shall then apply to the ESA/SCC Secretariat for a type variant number for each individual crystal unit concerned, by sending a finalised Table 1(a) which shall also be copied to the Qualifying Space Agency (QSA).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the crystal units specified herein, are as scheduled in Table 1(b).

1.4 PHYSICAL DIMENSIONS

The physical dimensions of the crystal units specified herein are shown in Figure 2.

1.5 FUNCTIONAL DIAGRAM

The functional diagram showing lead identification of the crystal units specified herein is shown in Figure 3.



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TABLE 1(a) - TYPE VARIANT SUMMARY

Variant	Resonance Frequency (MHz)	Frequency	Frequency C	Frequency C	Load Capacitance	Reference Temp.	Operating Temp. Range	Intended Applicat.	Lead L (Dim. I	.ength _ mm)
		(C _L pF)	(T _o ℃)	(T _{op} ℃)	nppilout.	Min.	Max.			
01	2.0736	30	+ 25	-55 to +105	-	25.0	26.0			
02	2.0	30	+ 25	-20 to +60	-	25.0	26.0			
03	2.4576	20	+ 25	-40 to +70	-	25.0	26.0			
04	2.304	30	+ 25	-40 to +70	-	25.0	26.0			
25	20.125984	27.5	+ 56	+ 53 to + 58	1	25.0	26.0			
60	1.536	30	+ 25	0 to +80	-	25.0	26.0			

NOTES

1. Full electrical and physical characteristics are given in the individual Tables 1(a) at the end of this specification.



TABLE 1(b) - MAXIMUM RATINGS

No.	Characteristic	Symbol	Values	Unit	Remarks
1	Nominal Frequency Range	f	0.8 to 50	MHz	Note 1
2	Drive Level Range	Р	0.1 to 2.0	mW	
3	Operating Temperature Range	T _{op}	-	°C	Note 2
4	Storage Temperature Range	T _{stg}	-65 to +125	°C	Note 3
5	Soldering Temperature	T _{sol}	+260	°C	Note 4

NOTES

Fundamental and Overtone Order	Approx. Frequency Range (MHz)
Fundamental	0.8 to 10
3	10 to 30
5	15 to 50

2. See Table 1(a).

3. The duration at maximum storage temperature shall not exceed 16 hours.

4. Duration 10 seconds maximum at a distance of not less than 3.0mm from the device body and the same lead shall not be resoldered until 3 minutes have elapsed.



TABLE 1(c) - FORMAT FOR INDIVIDUAL TABLES 1(a)

TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

TYPE VARIANT NO.

No.	Characteristic	Symbol	Lin	nits		_
		Symbol	Min.	Max	Unit	Remarks
1	Resonance Frequency	f _r or f∟			MHz	Note 1
2	Reference Temperature	Т _о			°C	Note 2
3	Overtone Order	-				
4	Load Capacitance	CL			pF	Note 3
5	Rated Drive Level	Po			mW	Note 4
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$			10 ⁻⁶	At T _o °C Note 5
7	Resonance Resistance	R _r or R _L			Ω	At To °C Note 6
8	Frequency Variation with Temperature over T _{op}	$\frac{\Delta f}{f}$			10- ⁹	From frequency measured at T _o °C Note 7
9	Resistance Variation with Temperature over T _{op}	∆ R R			%	From resistance measured at T _o °C Note 7
10	Operating Temperature Range	T _{op}			°C	
11	Frequency variation with Drive Level	<u>∆ f</u> f			10-6	From P _{S1} = mW to P _{S2} = mW Note 8
12	Resistance variation with Drive Level	<u>∆ R</u> R			%	From $P_{S1} = mW$ to $P_{S2} = mW$ Note 8
13	Motional Inductance	L ₁			mH	Notes 9 and 10
14	Motional Capacitance	C ₁			fF	Note 9
15	Static Capacitance	Co			pF	Note 9
16	Q Factor	Q			-	Notes 9 and 11
17	Ratio of unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	R _p /R or IZ _p I/R				In the frequency range: f - kHz to f + kHz
18	Ageing	$\frac{\Delta f}{f}$			10-6	Note 13
19	Terminal length	С			mm	Note 14
20	Intended Application					Note 16

NOTES: See Pages 9 and 10.



NOTES TO TABLE 1(c)

- 1. (a) If C_L is not specified, Symbol and measurement shall be f_r .
 - (b) If CL is specified, Symbol and measurement shall be fL.
- 2. Reference Temperature To
 - (a) For a crystal unit functioning in a non-controlled temperature environment, the reference temperature is normally +25 ±2 °C.
 - (b) For a crystal unit functioning in a controlled temperature environment, the reference temperature shall normally be the mid-point of the temperature range of the controlled environment.

3. Load Capacitance CL

- (a) When a crystal unit must function at its series resonance frequency, C_L shall be infinite.
- (b) When a crystal must function with a load capacitance, the CL value shall be specified. The standard values of load capacitance are as follows:
- Fundamental Frequency Operation: 20pF, 30pF, 50pF and 100pF.
- Overtone Operation: 8pF, 12pF, 15pF, 20pF and 30pF.

N.B

The tolerance on the load capacitance shall be that value which results in a frequency change not exceeding 10% of the frequency tolerance at To or 1% of the nominal load capacitance, whichever is smaller.

4. Rated Drive Level Po

The rated drive level shall be selected from the standard drive levels specified below:

- Preferred values: 2mW, 1mW, 0.5mW, 0.2mW, 0.1mW, 0.05mW, 0.02mW, 0.01mW, 0.001mW or 0.0001mW at ±20%.
- Non-preferred values: 10mW, 5mW and 4mW all at ±20%.
- 5. Frequency Adjustment Tolerance
 - (a) When a crystal must function at its series resonance frequency, the standard value of the adjustment tolerance shall be ±10 x 10-6.
 - (b) When a crystal has to function with a load capacitance, the standard value of the adjustment tolerance shall also be ±10 x 10⁻⁶. However, if the load capacitance is adjustable, it is preferable to specify that the nominal frequency be obtained with a load capacitance value between the minimum and maximum value when the crystal is functioning in its fundamental mode.
- 6. Resonance Resistance
 - (a) Generally, the maximum value only is specified.
 - (b) R_L may be calculated by R_L = R_r $\left(1 + \frac{C_0}{C_l}\right)^2$
- 7. Frequency and Resistance Variation with Temperature

These values shall be specified such that they are consistent with the operating temperature range.

8. Frequency and Resistance Variation with Drive Level

These limits and the Drive Level range (PS1 to PS2) shall be specified for very special crystals only (i.e. crystals used in very high stability oscillators).



NOTES TO TABLE 1(c) (Continued)

9. Electrical Values

The electrical values shall be specified only when required for the correct functioning of the equipment in which the crystal is used.

10. Motional Inductance L1

Because the inductance value may be restricted by other chosen parameters, the Manufacturer shall propose the value of L₁ in accordance with the Customer's requirements.

11. 'Q' Factor

If 'R' and 'L' have been already specified, it will not be necessary to specify the minimum value of the 'Q' factor.

The maximum value of the 'Q' factor is never specified.

12. Ratio of Unwanted Response Resistance to Resonance Resistance

The standard minimum value is 2, but it is possible to obtain higher values.

The frequency range within which the minimum value of the ratio is required shall also be specified.

13. Ageing

Specify limits under appropriate column and ageing period under "Remarks".

14. Terminal Lengths

To be specified if different from Figure 2 dimensions. If dimensions are as per Figure 2 then "Figure 2" to be entered in the Limits column.

15. Not applicable Items

For all items where limits are not specified, "Not applicable" shall be entered in the Limits column.

16. Intended Application

For definitions of the selected symbols to be added, see ESA/SCC Generic Specification No. 3501, Para. 3.



FIGURE 1 - PARAMETER DERATING INFORMATION

Not applicable.

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FIGURE 2 - PHYSICAL DIMENSIONS

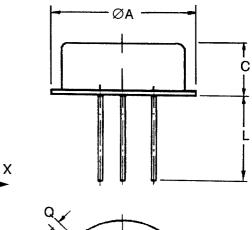
λY

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Symbol	Millim	netres	Demerica
Symbol	Min.	Max.	Remarks
ØA	-	22.00	
С	-	11.60	
Н	9.29	9.77	Pitch 9.52mm
ØK	0.40	0.48	
L	12.70	-	
Р	-	0.90	Note 2
Q	-	0.95	Note 2



- 1. Lead No. 4 is grounded to case.
- 2. The tag's position or presence is optional.



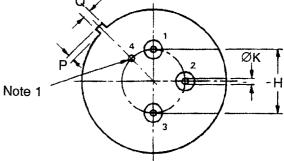
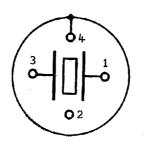


FIGURE 3 - FUNCTIONAL DIAGRAM



(Bottom View)

NOTES

- 1. Crystal connections 1 and 3.
- 2. Terminal 4 connected to Case.
- 3. Terminal 2 not connected.



2. <u>APPLICABLE DOCUMENTS</u>

The following documents form part of this specification and shall be read in conjunction with it:-

(a) ESA/SCC Generic Specification No. 3501 for Quartz Crystal Units.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following symbols are used:-

Resonance Frequency	= f _r
Load Resonance Frequency	$= f_L$
Reference Temperature	$= \overline{T_0}$
Resonance Resistance	$= R_r$
Load Resonance Resistance	$= R_{I}$
Rated Drive Level	$= P_0$
Static Capacitance	$= C_0$
Load Capacitance	= Ci
Motional Capacitance	$= C_1^{-1}$
Motional Inductance	= L ₁
Response Resistance	= R _P
Response Impedance	= IZpI
Insulation Resistance	= Ri

4. <u>REQUIREMENTS</u>

4.1 <u>GENERAL</u>

The complete requirements for procurement of the crystal units specified herein shall be as stated in this specification and ESA/SCC Generic Specification No. 3501 for Quartz Crystal Units. Deviations from the Generic Specification applicable to this specification only, are detailed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

- 4.2.1 <u>Deviations from Special In-process Controls</u> None.
- 4.2.2 <u>Deviations from Final Production Tests (Chart II)</u> None.
- 4.2.3 <u>Deviations from Burn-in Tests (Chart III)</u> None.
- 4.2.4 <u>Deviations from Qualification Tests (Chart IV)</u> None.
- 4.2.5 <u>Deviations from Lot Acceptance Tests (Chart V)</u> None.



4.3 MECHANICAL REQUIREMENTS

4.3.1 Dimension Check

The dimensions of the crystal units specified herein shall be checked. They shall conform to those shown in Figure 2.

4.3.2 Weight

The maximum weight of the crystal units specified herein shall be 7.0 grammes.

4.3.3 <u>Robustness of Terminations</u>

The requirements for robustness of termination testing are specified in Section 9 of ESA/SCC Generic Specification No. 3501.

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the crystal units specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 <u>Case</u>

4.4.1.1 Cap

Copper, nickel plated and gold plated.

4.4.1.2 Base

Kovar, nickel plated and gold plated.

4.4.2 Lead Material and Finish

The lead material shall be Type 'D' with Type '2' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

4.5 <u>MARKING</u>

4.5.1 General

The marking of all components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precendence, shall be as follows:-

- (a) The SCC Component Number.
- (b) Characteristics.
- (c) Traceability Information.

4.5.2 <u>The SCC Component Number</u>

Each component shall bear the SCC Component Number, which shall be constituted and marked as follows:-

	<u>350100301B</u>
Detail Specification Number	
Type Variant, (see Table 1(a))	
Testing Level (B or C, as applicable)	



4.5.3 Characteristics

The resonance frequency of the crystal units shall be clearly specified in MHz. Where necessary, it shall be specified to 6 decimal places.

4.5.4 Traceability Information

Each component shall be marked in respect of traceability information in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

4.5.5 Manufacturer's Name, Symbol or Code

The Manufacturer's marking shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

4.6 ELECTRICAL MEASUREMENTS

4.6.1 <u>Electrical Measurements at Reference Temperature</u>

The parameters to be measured in respect of electrical characteristics are scheduled in Table 2. The measurements shall be performed at the temperatures specified in the individual Tables 1(a), Item 2.

4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured at high and low temperatures are scheduled in Table 3. These measurements shall only be performed if values are specified in Table 1(a) Items 8 and/or 9.

4.6.3 <u>Circuits for Electrical Measurements (Figure 4)</u>

Not applicable.

4.7 <u>BURN-IN TESTS</u>

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at $T_{amb} = T_0 \pm 2$ °C. The parameter drift values (Delta) applicable to the scheduled parameters shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 3501. The conditions for burn-in shall be as specified in Table 5 of this specification.

4.7.3 <u>Electrical Circuits for Burn-in (Figure 5)</u> Not applicable.



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TABLE 2 - ELECTRICAL MEASUREMENTS AT REFERENCE TEMPERATURE

No.	Characteristics	Symbol	ESA/SCC 3501 Test Method	Limits	Unit
1	Resonance frequency at reference temperature and rated drive level - with C_O - with C_L	f _r (T _o , P _o) f _L (T _o , P _o)	Para. 9.2.1.1	Table 1(a), Item 1 ± Item 6	MHz
2	Resonance resistance at reference temperature and rated drive level - with C_O - with C_L	R _r (T _o , P _o) R _L (T _o , P _o)	Para. 9.2.1.1	Table 1(a), Item 7	Ω
3	Frequency variation with Drive Level	$\frac{\Delta f}{f}$ (T _o , Δ P)	Para. 9.2.1.1	Table 1(a), Item 11	10 ⁻⁶
4	Resistance variation with Drive Level	<u>Δ R</u> (T _o , ΔP) R	Para. 9.2.1.1	Table 1(a), Item 12	%
5	Motional Inductance	L ₁	Para. 9.2.1.3	Table 1(a), Item 13	mH
6	Static Capacitance	Co	Para. 9.2.1.4	Table 1(a), Item 15	рF
7	Unwanted response	R _P /R or IZ _P I/R	Para. 9.2.1.5	Table 1(a), Item 17	-
8	Insulation Resistance	Ri	Para. 9.2.1.6	500 Min.	MΩ



TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No.	Characteristics	Symbol	ESA/SCC 3501 Test Method	Limits	Unit
9	Frequency variation with Temperature over T _{op}	<u>Δ f</u> (ΔΤ, Ρ _o) f	Para. 9.2.1.2	Table 1(a) Item 8	10-6
10	Resistance variation with Temperature over T _{op}	<u>Δ R</u> (ΔΤ, Ρ _o) R	Para. 9.2.1.2	Table 1(a) Item 9	%

FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable.

TABLE 4 - PARAMETER DRIFT VALUES

No.	Characteristics	Symbol	Spec. and/or Test Method	Test Conditions	Change Limits (Δ)	Unit
1	Resonance frequency drift	$\frac{\Delta f}{f}$	As per Table 2	As per Table 2	± 2.0	10-6
2	Resonance resistance drift	AR R	As per Table 2	As per Table 2	± 10 or (1) ± 1.0	% Ω

NOTES 1. Whichever is the highest value.

TABLE 5 - CONDITIONS FOR BURN-IN AND LIFE TEST

No.	Characteristics	Symbol	Condition	Unit
1	Ambient Temperature	T _{amb}	+85 ±5	°C

FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND LIFE TEST

Not applicable.



4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC</u> SPECIFICATION NO. 3501)

4.8.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = T_0 \pm 2$ °C.

4.8.2 Measurements and Inspections at Intermediate Points and on Completion of Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points and on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = T_0 \pm 2$ °C.

4.8.3 Conditions for Operating Life Test (Part of Endurance Testing)

The requirements for the operating life test are specified in Section 9 of ESA/SCC Generic Specification No. 3501. The test shall be performed as a high temperature storage test and the temperature to be applied shall be the maximum operating temperature specified in the individual Tables 1(a) given in this specification.



TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

1 1	ESA/SCC GENERIC S	PEC. NO. 3501	MEASUREMENTS /	AND INSPECTIONS		LII	MITS	
	ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	Min.	Max.	UNIT
	Electrical Measurements at Reference Temperature	Para. 9.2.4	Electrical Table 2 Measurements			Tab	 le 1(a) 	
02	Shock	Para. 9.3	Initial Measurements Resonance Frequency Resonance Resistance Final Measurements Resonance Frequency Drift Resonance Resistance Drift	Table 2 Item 1 Table 2 Item 2 Table 2 Item 1	f R <u>Δ f</u> f <u>Δ R</u> ΔR		2 Item 1 2 Item 2 + 1.0 + 10 + 1.0	10 ⁻⁶ % Ω
03	Vibration	Para. 9.4	Initial Measurements Resonance Frequency Resonance Resistance Final Measurements Resonance Frequency Drift Resonance Resistance Drift	Table 2 Item 1 Table 2 Item 2 Table 2 Item 1	f R <u>Δf</u> f <u>Δ</u> R R ΔR	-	2 Item 1 2 Item 2 + 1.0 + 10 + 1.0	10 ⁻⁶ %
04 క	Seal Test		Fine Leak Gross Leak	Para. 9.5.1 Para. 9.5.2		Para	. 9.5.1 . 9.5.2	52
05 F	Permanence of Marking		Final Measurements Visual Examination	No corrosion or obliteration of marking	-	-	-	-
06 E	External Visual Inspection		Final Measurements Visual Inspection	ESA/SCC No. 20500	-	-	_	
07 S	Solderability	Para. 9.13	-	-	-	-	-	-

NOTES

1. The tests in this table refer to either Chart IV or V, and shall be used as applicable.

2. Whichever is the highest value.



TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (Cont.)

	ESA/SCC GENERIC S	SPEC. NO. 3501	MEASUREMENTS A	ND INSPECTIONS		LI	MITS	
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	Min.	Max.	UNIT
08	Climatic Sequence Dry Heat	Para. 9.14 Para. 9.14.1	Initial Measurements					
			Resonance Frequency Resonance Resistance Final Measurements	Table 2 Item 1 Table 2 Item 2	f R		2 Item 1 2 Item 2	
			Resonance Frequency Drift	Table 2 Item 1	$\frac{\Delta f}{f}$	- 2.0	+ 2.0	10 ⁻⁶
			Resonance Resistance Drift	Table 2 Item 2	AR R	- 10 or (2)	+10	%
09	Cold	Para. 9.14.3	Initial Measurements		ΔR	- 1.0	+ 1.0	Ω
			Resonance Frequency Resonance Resistance Final Measurements	Table 2 Item 2	f R		9.14.1.3 asurements	
			Resonance Frequency Drift		$\frac{\Delta f}{f}$	-2.0	+ 2.0	10 ⁻⁶
			Resonance Resistance Drift	Table 2 Item 2	AR R	- 10 or (2)	+ 10	%
10	Damp Heat (Acclerated)	Para. 9.14.4	Initial Measurements		ΔR	- 1.0	+ 1.0	Ω
	Remaining Cycles		Resonance Frequency Resonance Resistance Final Measurements	Table 2 Item 1	f R		9.14.3.2 asurements	
			Resonance Frequency	Table 2 Item 1	∆f f	-2.0	+ 2.0	10 ⁻⁶
			Resonance Resistance Drift	Table 2 Item 2	<u>Δ R</u> R	- 10 or (2)	+ 10	%
			Insulation Resistance	Table 2 Item 8	∆R Ri	- 1.0 500	+ 1.0 -	Ω ΜΩ
11	Rapid Change of Temperature		Initial Measurements Resonance Frequency Resonance Resistance Final Measurements	Table 2 Item 1 Table 2 Item 2 After minimum	f R		0.14.4.2 surements	
			Resonance Frequency Drift	Recovery of 2 hours Table 2 Item 1	$\frac{\Delta f}{f}$	- 2.0	+ 2.0	10 ⁻⁶
			Resonance Resistance Drift	Table 2 Item 2	<u>Δ R</u> R	- 10 or (2)	+ 10	%
12	Robustness of	Para. 9.16	Tensile Strength	0	ΔR	- 1.0	+1.0	Ω
	Terminations		Visual Examination Bending	Gen. 3501 Para. 9.16.1 No visible damage Gen. 3501 Para. 9.16.2				
			Visual Examination	No visible damage				

NOTES

1. The tests in this table refer to either Chart IV or V, and shall be used as applicable.

2. Whichever is the highest value.



TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (Cont.)

NO	NO.		MEASUREMENTS AND IN	ISPECTIONS		LIMITS		
			IDENTIFICATION	CONDITIONS	SYMBOL	Min.	Max.	UNIT
13	Life Test		Initial Measurements Resonance Frequency Resonance Resistance Intermediate Measurements Resonance Frequency Drift Resonance Resistance Drift Intermediate Measurements (Chart IV) and Final Measurements (Chart V) Resonance Frequency Drift Resonance Resistance Drift Final Measurements (Chart IV) Resonance Frequency Drift Resonance Frequency Drift Resonance Resistance Drift	Table 2 Item 1 Table 2 Item 2	f $\frac{\Delta f}{f}$ $\frac{\Delta f}{R}$ $\frac{\Delta f}{R}$ $\frac{\Delta f}{f}$ $\frac{\Delta f}{f}$ $\frac{\Delta f}{f}$ $\frac{\Delta f}{R}$ $\frac{\Delta f}{R}$ $\frac{\Delta A}{R}$ $\frac{\Delta A}{R}$	Table 2 Table 2 - 2.0 - 10 or (2) - 1.0 - 2.5 - 10 or (2) - 1.0 - 3.0 - 10 or (2) - 1.0	2 Item 1 2 Item 2 + 2.0 + 10 + 1.0 + 2.5 + 10 + 1.0 + 3.0 + 10 + 1.0	10-6 % Ω 10-6 % Ω 10-6 % Ω

NOTES

1. The tests in this table refer to either Chart IV or V, and shall be used as applicable.

2. Whichever is the highest value.



TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Li Min.	mits Max.	Unit	Remarks
1	Resonance Frequency	fL	2.0	2.0736		
2	Reference Temperature	То	+	- 25	°C	
3	Overtone Order	-	Funda	amental	-	
4	Load Capacitance	CL		30	pF	
5	Rated Drive Level	Po	().1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	-10	+ 10	10-6	At T _o °C
7	Resonance Resistance	RL	-	100	Ω	Over T _{op} °C
8	Frequency Variation with Temperature over T _{op}	$\frac{\Delta f}{f}$	-50	+ 50	10 ⁻⁶	From frequency measured at T _o °C
9	Resistance Variation with Temperature over T _{op}	AR R	Not ap	Not applicable		
10	Operating Temperature Range	T _{op}	-55	+ 105	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not ap	plicable	10 ⁻⁶	
12	Resistance Variation with Drive Level	ΔR R	Not ap	plicable	%	
13	Motional Inductance	L ₁	Not ap	olicable	mH	
14	Motional Capacitance	C ₁	Not ap	olicable	fF	
15	Static Capacitance	Co	-	7.0	pF	
16	Q Factor	Q	100 000		-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R iZpi/R	3:1	-		In the frequency range: f _L -200kHz to f _L + 200kHz
18	Ageing	$\frac{\Delta f}{f}$	-2.0	+2.0	10-6	After burn-in and per year
19	Terminal Length	L	Figur	re 2	mm	



TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Liı Min.	nits Max.	Unit	Remarks
1	Resonance Frequency	fL	2	2.0		
2	Reference Temperature	To	+	25	°C	
3	Overtone Order	-	Funda	amental		
4	Load Capacitance	CL	:	30	pF	
5	Rated Drive Level	Po	C).1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	-10	+ 10	10 ⁻⁶	At T _o °C
7	Resonance Resistance	RL	-	400	Ω	At T _o °C
8	Frequency Variation with Temperature over T _{op}	$\frac{\Delta f}{f}$	-40	+ 40	10 ⁻⁶	From frequency measured at T _o °C
9	Resistance Variation with Temperature over T _{op}	AR R	-10	+ 10	%	From resistance measured at T _o °C
10	Operating Temperature Range	T _{op}	-20	+ 60	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not ap	plicable	10 ⁻⁶	
12	Resistance Variation with Drive Level	Δ <u>R</u> R	Not ap	plicable	%	
13	Motional Inductance	L ₁	Not ap	olicable	mH	
14	Motional Capacitance	C ₁	Not ap	olicable	fF	
15	Static Capacitance	Co	Not app	olicable	pF	
16	Q Factor	Q	Not app	olicable	-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpl/R	3:1	-		In the frequency range: f _L -200kHz to f _L + 200kHz
18	Ageing	$\frac{\Delta f}{f}$	-3.0	+ 3.0	10-6	After burn-in and per year
19	Terminal Length	L	Figur	re 2	mm	



TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Li Min.	mits Max.	Unit	Remarks
1	Resonance Frequency	fL	2.4	2.4576		
2	Reference Temperature	То	+	- 25	°C	
3	Overtone Order	-	Funda	amental	-	
4	Load Capacitance	CL		20	pF	
5	Rated Drive Level	Po	(D.1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	-10	+ 10	10 ⁻⁶	At T _o °C
7	Resonance Resistance	RL	-	500	Ω	At T _o °C
8	Frequency Variation with Temperature over T _{op}	$\frac{\Delta f}{f}$	-100	+ 100	10-6	From frequency measured at T _o °C
9	Resistance Variation with Temperature over T _{op}	AR R	-20	+ 20	%	From resistance measured at T ₀ °C
10	Operating Temperature Range	T _{op}	-40	+ 70	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not ap	plicable	10-6	
12	Resistance Variation with Drive Level	ΔR R	Not ap	plicable	%	
13	Motional Inductance	L1	Not ap	plicable	mH	
14	Motional Capacitance	C ₁	Not ap	plicable	fF	
15	Static Capacitance	Co	Not ap	plicable	pF	
16	Q Factor	Q	Not ap	plicable	-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpI/R	Not applicable			-
18	Ageing	$\frac{\Delta f}{f}$	-100	+ 100	10-6	Over 6 years
19	Terminal Length	L	Figu	re 2	mm	



TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Liı Min.	mits Max.	Unit	Remarks
1	Resonance Frequency	fL	2.304		MHz	
2	Reference Temperature	То	+	25	°C	
3	Overtone Order	-	Funda	amental	-	
4	Load Capacitance	CL	:	30	pF	
5	Rated Drive Level	Po	0).1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	-10	+ 10	10 ⁻⁶	At T _o °C
7	Resonance Resistance	RL	-	500	Ω	At T _o °C
8	Frequency Variation with Temperature over T _{op}	$\frac{\Delta f}{f}$	-100	+ 100	10-6	From frequency measured at T _o °C
9	Resistance Variation with Temperature over T _{op}	AR R	-20	+20	%	From resistance measured at T _o °C
10	Operating Temperature Range	T _{op}	-40	+ 70	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not ap	plicable	10-6	
12	Resistance Variation with Drive Level	ΔR R	Not ap	plicable	%	
13	Motional Inductance	L1	Not ap	plicable	mH	
14	Motional Capacitance	C ₁	Not ap	plicable	fF	
15	Static Capacitance	Co	Not ap	plicable	рF	
16	Q Factor	Q	Not ap	plicable	-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpl/R	Not applicable			
18	Ageing	$\frac{\Delta f}{f}$	-100	+ 100	10-6	Over 6 years
19	Terminal Length	L	Figu	re 2	mm	



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TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Lin Min.	nits Max.	Unit	Remarks
1	Resonance Frequency	fL	20.12	20.125984		
2	Reference Temperature	То	+ 55	+ 58	°C	
3	Overtone Order	-		5		
4	Load Capacitance	CL	20	35	pF	
5	Rated Drive Level	Po	0	.1	mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	Not ap	plicable	10-6	
7	Resonance Resistance	RL	-	40	Ω	Over T _{op} °C
8	Frequency Variation with Temperature over T _{op}	$\frac{\Delta f}{f}$	-2.0	+2.0	10-6	From frequency measured at T _o °C
9	Resistance Variation with Temperature over T _{op}	AR R	Not applicable		%	
10	Operating Temperature Range	T _{op}	+ 53	+ 58	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not app	olicable	10-6	
12	Resistance Variation with Drive Level	Δ <u>R</u> R	Not app	blicable	%	
13	Motional Inductance	L ₁	Not app	olicable	mH	
14	Motional Capacitance	C ₁	Not app	olicable	fF	
15	Static Capacitance	Co	Not app	licable	рF	
16	Q Factor	Q	400 000	-	-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpI/R	Not applicable			
18	Ageing	$\frac{\Delta f}{f}$	Not applicable		10 ⁻⁶	
19	Terminal Length	L	Figur	e 2	mm	



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TABLE 1(a) - TYPE VARIANT DETAILED INFORMATION

No.	Characteristics	Symbol	Li Min.	mits Max.	Unit	Remarks
1	Resonance Frequency	fL	1.536		MHz	
2	Reference Temperature	Τ _ο	+ 25		°C	
3	Overtone Order	-	Fundamental			
4	Load Capacitance	CL	30		pF	
5	Rated Drive Level	Po	1.0		mW	
6	Frequency Adjustment Tolerance	$\frac{\Delta f}{f}$	-20	+ 20	10 ⁻⁶	At T _o °C
7	Resonance Resistance	RL	-	300	Ω	Over T _{op} °C
8	Frequency Variation with Temperature over T _{op}	$\frac{\Delta f}{f}$	-20	+ 20	10 ⁻⁶	From frequency measured at T _o °C
9	Resistance Variation with Temperature over T _{op}	AR R	Not applicable		%	
10	Operating Temperature Range	T _{op}	0	+ 80	°C	
11	Frequency Variation with Drive Level	$\frac{\Delta f}{f}$	Not applicable		10-6	
12	Resistance Variation with Drive Level	Δ <u>R</u> R	Not applicable		%	
13	Motional Inductance	L1	Not applicable		mH	
14	Motional Capacitance	C ₁	Not applicable		fF	
15	Static Capacitance	Co	-	7.0	pF	
16	Q Factor	Q	Not applicable		-	
17	Ratio of Unwanted: Response Resistance to Resonance Resistance or Response Impedance to Resonance Resistance	Rp/R IZpI/R	2:1	-		In the frequency range: f _L -1.0MHz to f _L +1.0MHz
18	Ageing	<u>∆ f</u> f	-5.0	+ 5.0	10-6	
19	Terminal Length	L	Figure 2		mm	